Wavefront reconstruction using multiple directional derivatives and Fourier transform

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Abstract. We present a Fourier-based regularized method for reconstructing the wavefront from multiple directional derivatives. This method is robust to noise, and is specially suited for deflectometry measurement. The resultant measurement of this technique is the directional derivative of a wavefront defined by

\[ W(x, y) = \sum_{k} \{ [W(x + 1, y) - W(x, y)] \cos \phi_k + [W(x, y + 1) - W(x, y)] \sin \phi_k - \phi^k(x, y) \} \]

where the indices \( k \) represent different derivatives and \( \phi^k(x, y) \) is the measurement direction of a sensor, \( k = 1, \ldots, K \) with \( K \geq 2 \), and \( \phi^k \) represents the measurement and processing errors.

The deflection technique is used for a surface measurement where the local slopes are optically measured and the surface is reconstructed using an integration procedure. This approach has several advantages over a direct height measurement. The resultant measurement of this technique is the directional derivative of a wavefront \( W \), which is defined by

\[ \phi^k = \nabla \cdot \mathbf{v}_k + \eta^k = \cos \phi_k \frac{\partial W(x, y)}{\partial x} + \sin \phi_k \frac{\partial W(x, y)}{\partial y} + \eta^k, \]

where \( \mathbf{r} = (x, y) \) is a position in an \( M \times N \) rectangular grid of pixels, \( \mathbf{v}_k = (\cos \phi, \sin \phi) \) is the measurement direction of a sensor, \( k = 1, \ldots, K \) with \( K \geq 2 \), and \( \eta^k \) represents the measurement and processing errors.

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A common way to integrate the derivatives is to use a global integration method where most of the integration techniques only use two orthogonal directions in the measurement, that is \( \phi_1 \) and \( \phi_2 \) with \( \mathbf{v}_1 = (1, 0) \) and \( \mathbf{v}_2 = (0, 1) \). Recently, in Ref. a procedure was proposed that uses multiple directional derivatives, which reduces the noise contribution in the reconstruction of the wavefront. This consists of acquiring \( k \)-number of directional derivatives with different measurement direction, and the estimated wavefront \( W_e \) is computed as the minimizer of the following cost functional:

\[ J(W) = \sum_k \int \int | \nabla W \cdot \mathbf{v}_k - \phi^k |^2 \, dx \, dy + \lambda \int \int (|W_{xx}|^2 + |W_{xy}|^2 + |W_{yy}|^2) \, dx \, dy, \]

where the subscripts represent partial derivatives, and \( \lambda \) is the regularization parameter. The second term of this cost functional penalizes the strong oscillations in the curvature of the reconstructed wavefront through the term \( \lambda \).

The minimization of the above cost function is performed by means of Fourier transform theory. Taking the Fourier transform and using its properties, we obtain the minimizer of Eq. expressed as

\[ \hat{\phi}[W_e] = \frac{i}{\lambda} \sum_k \{ \hat{\phi}[\mathbf{q} \cdot \mathbf{v}_k] \} \]

where \( i = \sqrt{-1} \), \( \mathbf{q} = (u, v) \) is the position vector on frequency domain, and \( \hat{\phi} \) denotes the Fourier transform. This expression becomes the same reported in Ref. for the case of \( K = 2 \) with \( \mathbf{v}_1 = (1, 0) \) and \( \mathbf{v}_2 = (0, 1) \), and the case of \( \lambda = 0 \), Eq. becomes the same expression reported in Ref. For practical purposes, one has to consider that the discrete Fourier transform always needs full fields of valid data. The missing data, for instance due to occlusions in the...
measurement, has to be extrapolated by use of a Gershberg-type algorithm or an alternative technique.

The performance of the proposed technique is illustrated by two experiments. All numerical experiments were made in a 2.53 GHz Pentium Dual Core PC with 8 GB of main memory using Ubuntu 9.04 as the operative system. The algorithm used to compute the discrete Fourier transform was the FFTW library. The first experiment was a numerical estimation using the synthetic wavefront shown in Fig. 1(a). As mentioned above, a Gaussian noise with a signal-to-noise ratio equal to $-20$ db was added to 10 directional derivatives, which were generated by use of Eq. 1. The direction $v_k$ was equally spaced from $0^\circ$ to $180^\circ$, where every derivative is a $512 \times 512$ matrix. The resultant wavefront is shown in Fig. 1(d) using $\lambda = 20$. As one can observe, the artifacts in the reconstructed wavefront are notably reduced. The mean square error (MSE) obtained in each reconstruction is shown on Table 1.

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Fig. 1 (a) Synthetic wavefront. Wavefronts reconstructed with (b) Ref. 5, (c) Ref. 7, and (d) the proposed method with $\lambda = 20$.

Fig. 2 Experimental results: (a) Fringe pattern of a progressive lens in the deflectometry setup. Wavefronts reconstructed with (b) Ref. 5 and (c) the proposed method with $\lambda = 5$. The heights are represented in the same gray-scale.
Table 1 Mean square error for the reconstructed wavefronts.

<table>
<thead>
<tr>
<th>Method</th>
<th>MSE</th>
<th>Time employed (ms)</th>
</tr>
</thead>
<tbody>
<tr>
<td>Ref. 5</td>
<td>0.243157</td>
<td>9011</td>
</tr>
<tr>
<td>Ref. 7</td>
<td>0.320633</td>
<td>472</td>
</tr>
<tr>
<td>Eq. (4) $\lambda = 20$</td>
<td>0.147356</td>
<td>472</td>
</tr>
</tbody>
</table>

The second experiment was the reconstruction of a progressive lens surface. An example of the fringe pattern used in the experiment is shown in Fig. 2(a). Five directional derivatives were acquired using Eq. (1) with $v_k$ equally spaced from $0^\circ$ to $180^\circ$ with steps of $30^\circ$, where every image has a resolution of $2048 \times 1552$ pixels. The fringe patterns were processed using the procedure reported in Ref. [4].

The computational time employed for the reconstruction was nearly 879 ms using the proposed technique with $\lambda = 5$. In the case of the procedure of Ref. [5] the time employed was 272,275 ms. The resultant reconstructions are shown in Figs. 2(b) and 2(c). As one can observe, both reconstructions are similar where the uncertainty of both measurements are about 0.04 mm. However, there is a huge difference in the computational process employed for the reconstruction.

The performance of the cost functional proposed here, Eq. (3) and their minimizer given in Eq. (4) was proved with two fast and accurate reconstructions using a large number of directional derivatives, as it was shown in the results described above. One extra advantage of the proposed method is its feasibility to be implemented on a dedicated hardware for processing in real-time, which is the aim of future research.

Acknowledgments

The authors were supported in part by grants of the Consejo Nacional de Ciencia y Tecnologia (CONACyT).

References